

# CIRCULAR PHOTOVOLTAIC EFFECT IN AN ANISOTROPIC GRAPHENE SUPERLATTICE IN THE PRESENCE OF A CONSTANT ELECTRIC FIELD

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## I. INTRODUCTION

The unique electrical and optical properties of graphene-based materials and the development of techniques for fabricating low-dimensional structures motivate intensive efforts to implement graphene-based nano- and optoelectronics. However, the pseudo-relativistic behavior of charge carriers was found in the energy bands of not only graphene.

There is a certain class of two-dimensional (2D) materials, which includes graphene, silicene, germanene, phosphoric, etc. It is called Dirac materials or graphene-like materials. Currently, the possibility of creating an electronic band structure of graphene by using an additional periodic potential has aroused increased research interest in superlattices (SLs) based on graphene-like materials (GSL) [1]. In this paper, the influence of a constant electric field on the circular photovoltaic effect in an anisotropic GSL at normal incidence are investigated. The expression for the current density in such a superlattice is obtained.

## II. MAIN FORMULAS

The energy spectrum of the structure in the low-energy approximation has the following form [2]

$$\varepsilon(\mathbf{p}) = \pm 2F \sqrt{\sin^2\left(\frac{p_x}{2}\right) + \frac{1}{4}(p_y^2 + \Delta_{eff})^2} \quad (1)$$

where  $\Delta_{eff} = \frac{\Delta_1 + n\Delta_2}{1+n}$ ,  $F = \frac{Q}{shQ}$ ,  $Q = \frac{n(\Delta_1 - \Delta_2)}{(1+n)^2}$ ,  $n=b/a$ ,  $a$  is the height of the hole,  $b$  is the barrier width,  $p_x = p_x d$ ,  $p_y^2 = \alpha p_y^2 d / v_F$ ,  $d = a + b$ . Different signs are applicable the valence and conduction bands.

We will consider the response of the superlattice to the action of constant and alternating electric fields.  $\vec{E} = (E_{0x} \cos(\omega t) + E_0; E_{0y} \cos(\omega t + \varphi))$  where  $E_0$  is the modulus of the intensity of the constant electric field,  $E_{0x,y}$ ,  $\omega$  are the amplitude and frequency of the alternating electric field.

The current density  $j_y$ , along the Y-axis is determined by the formula:

$$j_y = \langle e \sum_p v_y f(\mathbf{p}, t) \rangle_t \quad (2)$$

where  $e$  is the electron charge,  $f(\mathbf{p}, t)$  is the nonequilibrium carrier distribution function.

The distribution function will be found using the classical Boltzmann equation

$$\frac{\partial f(\mathbf{p}, t)}{\partial t} + e\mathbf{E} \frac{\partial f(\mathbf{p}, t)}{\partial p} = -v[f(\mathbf{p}, t) - f_0(\mathbf{p})] \quad (3)$$

where  $f_0(\mathbf{p})$  is the equilibrium distribution function.

The electron velocity along the Y-axis is given by

$$v_y = \frac{\partial \varepsilon(\mathbf{p})}{\partial p_y} = \frac{F p_y (p_y^2 + \Delta_{eff})}{\sqrt{\sin^2(\frac{p_x}{2}) + \frac{1}{4}(p_y^2 + \Delta_{eff})^2}} \quad (4)$$

After expanding the velocity in terms of  $p_y$ , we get the following expression

$$v_y \approx \frac{2F \Delta_{eff} p_y}{\sqrt{\sin^2(\frac{p_x}{2}) + \Delta_{eff}^2}} \quad (5)$$

$$v'_y(x) = \frac{1}{\sqrt{\sin^2(\frac{p_x}{2}) + \Delta_{eff}^2}} \quad (6)$$

Expand (6) into a complex Fourier series

$$v'_y(x) = \sum_{m=-\infty}^{+\infty} \hat{a}_m e^{imx} \quad (7)$$

where  $\hat{a}_m = \frac{1}{2\pi} \int_{-\pi}^{\pi} \frac{e^{imx} dx}{\sqrt{\sin^2(\frac{p_x}{2}) + \Delta_{eff}^2}} = \frac{{}_3F_2(\frac{1}{2}, 1; 1-m, m+1; 4/(\Delta_{eff}^2+4))}{\sqrt{\Delta_{eff}^2+4}}$ .

Solving equation (3) by the method of characteristics, substituting it and (4) in (2), an expression for the constant component of the current is obtained.

$$j_y = \frac{2ev}{(2\pi\hbar)^2} \left( \int_{-\pi}^{\pi} \int_{-\infty}^{\infty} \int_{-\infty}^{\infty} e^{-v(t-t')} v_y(p_x; p_y) \times f_0(p_x - \frac{e}{c}(A_x(t) - A_x(t')); p_y - \frac{e}{c}(A_y(t) - A_y(t'))) d^2 p dt' \right) \quad (8)$$

We substitute (5) taking into account the expansion (7) into (8), integrate, and after some transformations, expression (8) takes the form:

$$j_y = j_0 \text{Re} \left[ \sum_{m=-\infty}^{+\infty} \hat{a}_m C_m \sum_{l=-\infty}^{\infty} \frac{\beta_{oy} J_l I_{l+1}(\alpha_{ox}) \cos(\varphi)}{(\tilde{\alpha}_0 - i\tilde{v} + l)(\tilde{\alpha}_0 - i\tilde{v} + (l+1))} dx dy \right] \quad (9)$$

where  $\tilde{v} = v/\omega$ ,  $\alpha_{ox} = \frac{medE_{0x}}{\hbar\omega}$ ,  $\alpha_0 = \frac{medE_0}{\hbar}$ ,  $\beta_{oy} = \sqrt{\frac{\alpha d}{v_F \hbar \omega}} E_{0y}$ ,  $\tilde{\alpha}_0 = \alpha_0/\omega$ ,  $C_m = \frac{1}{I_0} \int_{-\pi}^{\pi} \int_{-\infty}^{\infty} e^{-\frac{\varepsilon(x,y)}{kT}} e^{imx}$ ,  $I_0 = \int_{-\infty}^{\infty} \int_{-\pi}^{\pi} e^{-\frac{\varepsilon(x,y)}{kT}} dx dy$ ,  $j_0 = \frac{\hbar e \tilde{v} F \Delta_{eff} n_0}{d} \sqrt{\frac{v_F \hbar}{\alpha d}}$ ,  $v_F = 10^8$  cm / s,  $J_l(z)$  is the Bessel function.

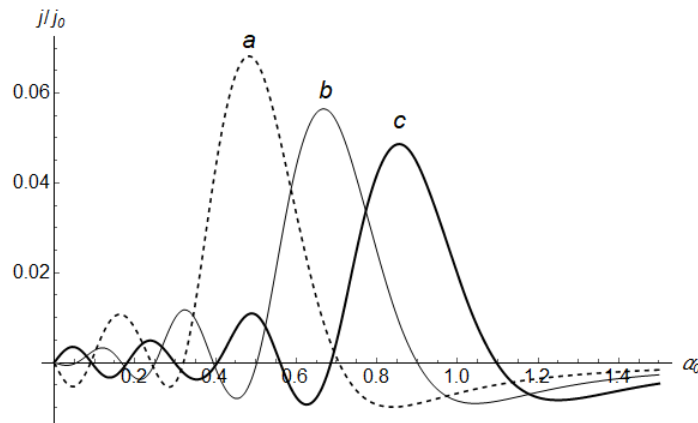


Figure 1. Dependence of the current density on the strength of a constant electric field applied along the X-axis at fixed values of  $\beta_{oy} = 1.0$  and  $\varphi = \pi/4$  a)  $\alpha_{ox} = 0.6$  b)  $\alpha_{ox} = 0.8$  c)  $\alpha_{ox} = 1.0$

### III. CONCLUSIONS

The influence of a constant electric field on the circular photovoltaic effect in an anisotropic graphene superlattice at normal incidence is investigated. An expression is obtained for the current density in such a superlattice. The features of the photovoltaic effect in such a structure are noted. The dependence of the

current density on the strengths of the applied fields has a non-monotonic, oscillating, alternating character (Figure 1). The largest amplitude of oscillations is achieved in the region of low fields.

## REFERENCES

- [1] D.V. Zav'yalov, V.I. Konchenkov, S.V. Kryuchkov, "Transverse current straightening in a graphene-based superlattice", Semiconductors, Vol. 46(1), pp. 113-120, 2012.
- [2] E.I. Kukhar, S.V. Kryuchkov, "Topological phase transitions in superlattice based on 2D Dirac crystals with anisotropic dispersion" Superlattices and Microstructures, Vol.133, p. 106183, 2019.